


<b>Search Notes</b>  	<b>Application/Control No.</b>  10686396	<b>Applicant(s)/Patent Under Reexamination</b>  ISHIHARA, KEIICHIRO
	<b>Examiner</b>  Jonathan R Beckley	<b>Art Unit</b>  4178

SEARCHED			
Class	Subclass	Date	Examiner
358	2.99,2.1,3.24,3.26	11/1/2007	JB
359	202,220,210,206,212,364,714,649,14,234,201,205,619,819,207,254,726,783,744	11/1/2007	JB
250	235	11/1/2007	JB
73	620	11/1/2007	JB
353	7,98,74,82	11/1/2007	JB
356	630	11/1/2007	JB
345	9	11/1/2007	JB
600	178	11/1/2007	JB
349	113	11/1/2007	JB
358	2.99,2.1,3.24,3.26	5/22/2008	JB
359	202,220,210,206,212,364,714,649,14,234,201,205,619,819,207,254,726,783,744	5/22/2008	JB
358	2.99,2.1,3.24,3.26	12/18/2008	JB
359	202,220,210,206,212,364,714,649,14,234,201,205,619,819,207,254,726,783,744	12/18/2008	JB

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	7/3/2007	JB
EAST	10/24/2007	JB
EAST	10/25/2007	JB
EAST	10/29/2007	JB
EAST	10/31/2007	JB
EAST	11/1/2007	JB
CONSULTED WITH HAI TRAN	7/3/2007	JB
CONSULTED WITH SCOTT BEALIVEAU	10/31/2007	JB
EAST	5/22/2008	JB
EAST	12/18/2008	JB
CONSULTED WITH SCOTT BEALIVEAU	12/18/2008	JB
CONSULTED WITH VICTOR KOSTAK	12/18/2008	JB
CONSULTED WITH JOSEPH MARTINEZ	12/18/2008	JB
CONSULTED WITH JESSICA STULTZ	12/18/2008	JB

/JONATHAN R BECKLEY/ Examiner.Art Unit 2625	
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## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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